Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/649,875	YAMAGUCHI ET AL.		
Examiner	Art Unit		
Christopher M. Keehan	1712		

SEARCHED					
Class	Subclass	Date	Examiner		
528	401	5/3/2005	СМК		
	10				
428	447				
351	159				
	160R				
	166				
427	387				
	167				
	294				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
same as	above	5/3/2005	СМК		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	5/3/2005	СМК		
Inventor name search				
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